	Revision Record								
Revision	DCO	Description	Engineering Approval	Date	QA Approval	Date	Release Date		
-		Initial Release	EJ	7/19/07	TM	7/24/07	7/24/07		
Α		Correction Table III, add Table IV.					1/7/08		
В		Change mfgr, para 3.3.3. Update Table IV.					8/08/08		
С		Change mfgr to AC191 para 3.3.3.1, Table II maximum vcc, Table III freq range.					9/19/12		
D	5615	Change document format/number. Update microcircuit usage. Update Table 1, code H. Add typical jitter to Table 3, Icc.	CH RD	7/19/16 8/29/16	SD	8/17/16	8/29/16		
E	6879	Add EAR Destination Statement; corrected freq. breakpoints in 6.4.3.1 and Table 2.	Curtis Hooper Richard Duong	6/19/17 6/21/17	Daniel Moline	6/27/17	6/29/17		

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UNLESS OTHERWISE SPECIFIED								
Dimensions are in Inches								
Tolerances								
Decimal	Fraction	Angular						
.xxx ± .005								
.xx ± .02	$x/x \pm 1/16$	x° ± 2°						

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DETAIL PRODUCT SPECIFICATION CONTROL DRAWING						
Initial Release	Q-Tech Corporation					
Prepared	Date	10150 West Jefferson Boulevard			evard	
E. Jackson	7/19/07	Culver City, CA 90232-3510 USA				
Checked	Date			TITLE		
Basheer Remtulla	7/20/07	LIVERID CRYCTAL COCULATOR CLASS C				
Engineering Approval	Date	HYBRID CRYSTAL OSCILLATOR, CLASS S, QT606L, DETAIL SPECIFICATION FOR			*	
E. Jackson	7/19/07		(1606L, DETAIL	SPECIFICATION FO	'K	
Quality Assurance Approval	Date		DRAWING NO.		REVISION	
T. Mitchell	7/24/07	QPDS-0120 E				
Released	Date	SCALE	SIZE	CAGE CODE	PAGE	
T. Mitchell	7/24/07	NONE	Α	51774	1 of 6	

 $.x \pm .1$

1 PURPOSE

1.1 The purpose of this Detail Specification Control Drawing (SCD) is to describe the specific quality and reliability requirements for hybrid, hermetically sealed, crystal oscillators for use in space flight missions.

2 SCOPE

2.1 This specification establishes the minimum detail requirements for QT606L intended for use in conjunction with the applicable general SCD.

3 PART PROTECTION AND SAFETY

3.1 These items are susceptible to breakdown damage resulting from electrostatic discharge. Every precaution shall be taken while handling, installing, and testing the parts to prevent static charge. Care should be exercised to not apply more than rated voltage or current to any terminal/pad during testing.

4 PART NUMBER

4.1 The Q-Tech Part Number shall be as specified in Table 1 herein.

5 APPLICABLE DOCUMENTATION & REFERENCES

- 5.1 The following documents form a part of this drawing to the extent specified or modified herein.
- 5.2 **Q-Tech**
- 5.2.1 0401-00298-0001, Hybrid Crystal Oscillators, Class S, General Specification for
- 5.3 **Application of Documents**

5.3.1 **Issue of Documents**

Document revisions in effect on the date of the customer purchase order form a part of this drawing except as modified herein.

5.3.2 **Order of Precedence**

In the event of conflict between this document and the references cited herein or other requirements, the precedence in which requirements shall govern, in descending order, is as follows:

- a) Applicable Customer Purchase Order
- b) Applicable Q-Tech Corporation Detail SCD/Drawing
- c) Applicable Q-Tech Corporation General SCD
- d) Other Specifications, Standards, and Documentation Referenced Above

5.3.3 Customer Purchase Order Special Requirements

Additional special requirements shall be specified in the applicable customer purchase order when additional requirements or modifications are needed for compliance to special programs or product line compliance. Unique identification of the items produced may be required.

5.3.4 **General Specification Control Drawing**

Any reference to the "general specification" or "general SCD" refers to the Q-Tech Corporation General Specification Control Drawing cited in the Applicable Documentation and References section, unless otherwise specified.

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6 GENERAL REQUIREMENTS

6.1 **Definition of Requirements**

Items supplied to this detail SCD shall meet the detail requirements specified herein.

6.2 **Individual Item Requirements**

The individual item requirements shall be in accordance with Q-Tech Corporation General SCD 0401-00298-0001 with the exceptions, modifications, and additions herein.

6.3 **Approved Source of Supply**

Hybrid crystal oscillators shall be supplied from the manufacturer specified in "Source of Supply" below.

6.4 **Design and Construction**

6.4.1 Outline Dimensions and Terminal Connections

The outline dimensions and terminal connections shall be as shown in Figure 1 herein.

6.4.2 Package Body and Lead Finish

The package body and lead finish shall be gold in accordance with MIL-PRF-38534.

6.4.3 **Active Devices**

The microcircuit used in this part shall use CMOS technology and shall be from a wafer proven to be radiation tolerant to 100 KRad (Si) total ionizing dose.

6.4.3.1 CMOS Microcircuit Usage

For frequencies below 3.75 MHz, the CMOS output microcircuit shall be 54AC191, see DSCC SMD 5962-89749. For frequencies from 3.75 MHz but below 15MHz, the CMOS output microcircuit shall be 54AC74, see DSCC SMD 5962-88520. For frequencies greater than or equal to 15 MHz, the CMOS microcircuit shall be 54AC00, see DSCC SMD 5962-87549. These microcircuits are specified to be single event latchup free for LET up to 93 MeV-cm²/mg. For output frequencies up to 70 MHz, the manufacturer shall be ST Microelectronics Corporation. For output frequencies greater than 70 MHz, the manufacturer shall be National Semiconductor Corporation.

6.5 **Performance Requirements**

6.5.1 Maximum Ratings

The maximum ratings shall be as specified in Table 2 herein.

6.5.2 Electrical Performance Characteristics and Limits

The electrical performance requirements and limits shall be in accordance with Table 3 herein.

6.5.3 **Delta Limits**

Except for frequency aging (refer to Table 3 herein), delta limits shall be in accordance with the general SCD.

6.5.4 Total Dose Radiation Limits

Hybrid crystal oscillators supplied in accordance with this detail SCD shall be capable of meeting the performance requirements after being exposed to 100 KRad (Si) total dose radiation levels.

7 QUALITY ASSURANCE PROVISIONS

7.1 **General**

The quality assurance provisions shall be in accordance with the general SCD with the exceptions, modifications, and additions specified herein.

7.2 **Screening**

The screening tests shall be in accordance with the general SCD.

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7.3 Quality Conformance Inspection (QCI)

Quality Conformance Inspection shall be in accordance with the general SCD and shall be required only when specified by the purchase order.

8 PREPARATION FOR DELIVERY

8.1 Preservation, Packaging, and Packing

Hybrid crystal oscillators shall be prepared for delivery in accordance with the general SCD.

8.2 Electrostatic Discharge Sensitivity

The devices supplied to this detail SCD shall be considered to be electrostatic discharge sensitive and require further protection and shall use the packaging requirements class 1C in accordance with par. 3.9.5.8.2 of MIL-PRF-38534.

9 SOURCE OF SUPPLY

9.1 Approved Manufacturer

Q-Tech Corporation 10150 West Jefferson Boulevard Culver City, CA 90232-3510 USA

10 NOTES

The notes of the general SCD are applicable to this drawing.

10.2 Ordering Information

The procuring activity shall advise Q-Tech Corporation at the time of Request for Quotation if quality conformance inspection is to be required.

Table 1 – Part Number

Model Number	Supply Voltage	Temperature Stability	Screening	Frequency (MHz)
QT606	L: 3.3	A: ±65 PPM, -55°C to +125°C	E: Engineering Model	1.000000
		B: ±50 PPM, -55°C to +125°C	M: Flight Model	to
		C: ±50 PPM, -55°C to +105°C		100.000000
		D: ±40 PPM, -55°C to +105°C		
		E: ±30 PPM, -40°C to +85°C		
		F: ± 50 PPM, -20°C to +70°C		
		G: ±25 PPM, -20°C to +70°C		
		* H: ±5 PPM, 0°C to +55°C		

^{*} Frequency/Temperature stability (tolerance) shall be referenced to the specified nominal output frequency, except for temp code H, in which case it is referenced to room temperature (T = 25 ± 2 °C). For temp code H, room temperature tolerance shall be ± 15 PPM.

Part Number Examples

QT606LBM-16.000000MHz would be a Flight Model QT606, CMOS, 3.3 volts, stability ±50 PPM over -55°C to +125°C, @ 16MHz output.

QT606LEE-100.000000MHz would be an Engineering Model QT606, CMOS, 3.3 volts, stability ±30 PPM over -40°C to +85°C, @ 100MHz output.

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Table 2 – Maximum Ratings

Parameter	Symbol	Minimum	Maximum	Units
Supply Voltage	Vcc	0	7	Volts
Operating Temperature	Tc	-55	+125	°C
Storage Temperature	T _{STG}	-65	+150	°C
Lead Solder Temperature/Time			+250/10	°C/Seconds
Package Thermal Resistance	Θјς		50	°C/W

Table 3 – Electrical Performance Characteristics

	Test Conditions						
Electrical Parameter	(Note 2 and 3)	Min. Nom. Max.		Max.	Units	Notes	
Frequency Range		0.9375		100	MHz		
Frequency/Temperature Stability			See Table 1			Note 1, 4	
Supply Voltage		2.97	3.3	3.63	Vdc		
	Output Frequency:						
Input Current Measured without load at 3.63 Vdc	Below 60 MHz			15	mA		
Wedsared Without Ioud at 5.05 vae	60 MHz – 100 MHz			20	mA		
Load			CMOS			Note 6	
Output Voltage – Logic "0"				V _{cc} x 0.1	Vdc		
Output Voltage – Logic "1"		V _{cc} x 0.9			Vdc		
Output Waveform		Squarewave		N/A			
	Output Frequency:						
Rise / Fall Time	Up to 70 MHz			5	nsec	Note 7	
	> 70 MHz			3	nsec	Note 7	
Duty Cycle		40	50	60	%		
Frequency Aging (After 30 Days)	70°C ± 3°C			±1.5	ppm		
Frequency Aging (After 1 Year)	70°C ± 3°C			±10	ppm		
Start Up Time				10	msec		
	Output Frequency:						
Jitter (cycle-to-cycle, rms)	Less than 3.75 MHz			40	ps	Note 8	
	3.75 MHz – 100MHz			10	ps	Note 8	

NOTES

- 1. The limit for Frequency Stability (tolerance) is referenced to the specified nominal output frequency, except for temp code H as noted above.
- 2. Unless otherwise specified, the limits are over the full operating temperature range, and under specified load conditions and nominal Supply Voltage.
- ${\it 3.} \quad {\it Unless otherwise specified, all measurements are in accordance with MIL-PRF-55310}.$
- 4. Up to 30 days after shipment.
- 5. Voltage values are with respect to network ground terminal.
- 6. A standard CMOS load of 10 K Ω | | 15 pF shall be used. See MIL-PRF-55310/26 for CMOS waveform measurement definitions.
- 7. Measured between 10% Vdc and 90% Vdc.
- 8. Guaranteed by design, not tested.

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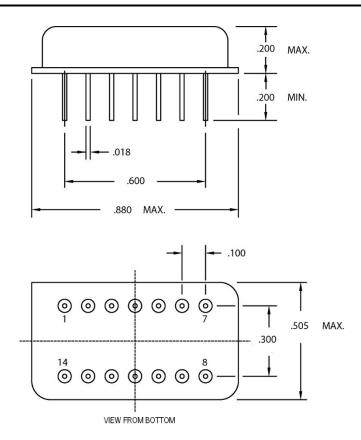


Figure 1 – Package Dimensions and Terminal Connections

Table 4 – Terminal Connections

Terminal No.	Connection	Terminal No.	Connection
1	N/C	8	OUTPUT
2	N/C	9	N/C
3	N/C	10	N/C
4	N/C	11	N/C
5	N/C	12	N/C
6	N/C	13	N/C
7	GROUND/CASE	14	Vcc

NOTES

- 1. Dimensions are in inches.
- 2. Lead numbers are for reference only and are not marked on the unit.
- 3. A triangle symbol is marked on the corner of the package to indicate Pin 1.